

## Pin Descriptions

| Pin Names | Description |
| :--- | :--- |
| $\overline{\mathrm{OE}}_{\mathrm{n}}$ | Output Enable Input |
| $\mathrm{T} / \bar{R}_{n}$ | Transmit/Receive Input |
| $\mathrm{A}_{0}-\mathrm{A}_{15}$ | A Bus Inputs/3-STATE Outputs |
| $\mathrm{B}_{0}-\mathrm{B}_{15}$ | B Bus Inputs/3-STATE Outputs |

## Truth Table

| Inputs |  |  |  | Output Operating Mode |  |
| :---: | :---: | :---: | :---: | :---: | :---: |
| Byte1 (0:7) |  | Byte2 (8:15) |  |  |  |
| $\overline{\mathrm{OE}}_{1}$ | T/ $\bar{R}_{1}$ | $\overline{\mathrm{OE}}_{2}$ | $\mathrm{T} / \bar{R}_{2}$ | Byte1 (0:7) | Byte2 (8:15) |
| L | L | H | X | Bus B Data to A | High Z State |
| L | H | H | X | Bus A Data to B | High Z State |
| H | X | L | L | High Z State | Bus B Data to A |
| H | X | L | H | High Z State | Bus A Data to B |
| L | L | L | L | Bus B Data to A | Bus B Data to A |
| L | H | L | H | Bus A Data to B | Bus A Data to B |
| H | X | H | X | High Z State | High Z State |

$\mathrm{H}=\mathrm{HIGH}$ Voltage Level
L = LOW Voltage Level
X = Immaterial

## Logic Diagram



## Absolute Maximum Ratings(Note 1)

Storage Temperature
Ambient Temperature under Bias Junction Temperature under Bias
$\mathrm{V}_{\mathrm{CC}}$ Pin Potential to Ground Pin Input Voltage (Note 2)

Input Current (Note 2)
Voltage Applied to Output
in HIGH State (with $\mathrm{V}_{\mathrm{CC}}=0 \mathrm{~V}$ )
Standard Output
3-STATE Output
Current Applied to Output
in LOW State (Max)
ESD Last Passing Voltage (Min)
Twice the Rated $\mathrm{IOL}_{\mathrm{OL}}(\mathrm{mA})$

DC Electrical Characteristics

| Symbol | Parameter | Min | Typ | Max | Units | $\mathrm{v}_{\mathrm{cc}}$ | Conditions |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\mathrm{H}}$ | Input HIGH Voltage | 2.0 |  |  | V |  | Recognized as a HIGH Signal |
| $\mathrm{V}_{\mathrm{IL}}$ | Input LOW Voltage |  |  | 0.8 | V |  | Recognized as a LOW Signal |
| $\mathrm{V}_{C D}$ | Input Clamp Diode Voltage |  |  | -1.2 | V | Min | $\mathrm{I}_{\mathrm{N}}=-18 \mathrm{~mA}$ |
| $\mathrm{V}_{\mathrm{OH}}$ | Output HIGH <br> Voltage | $\begin{aligned} & 2.4 \\ & 2.0 \end{aligned}$ | $\begin{gathered} 2.8 \\ 2.44 \end{gathered}$ |  | v | Min | $\begin{aligned} & \mathrm{l}_{\mathrm{OH}}=-3 \mathrm{~mA} \\ & \mathrm{I}_{\mathrm{OH}}=-15 \mathrm{~mA} \\ & \left(\mathrm{~A}_{\mathrm{n}}, \mathrm{~B}_{\mathrm{n}}\right) \end{aligned}$ |
| $\overline{\mathrm{V} \text { OL }}$ | Output LOW <br> Voltage |  | 0.45 | 0.55 | V | Min | $\begin{aligned} & \mathrm{I}_{\mathrm{OL}}=64 \mathrm{~mA} \\ & \left(\mathrm{~A}_{\mathrm{n}}, \mathrm{~B}_{\mathrm{n}}\right) \end{aligned}$ |
| $\overline{I_{H}}$ | Input HIGH Current |  |  | 5.0 | $\mu \mathrm{A}$ | Max | $\mathrm{V}_{1 \mathrm{~N}}=2.7 \mathrm{~V}$ |
| $\mathrm{l}_{\mathrm{BVI}}$ | Input HIGH Current <br> Break-Down Test |  |  | 7.0 | $\mu \mathrm{A}$ | Max | $\begin{aligned} & \begin{array}{l} \mathrm{V}_{\text {IN }}=7.0 \mathrm{~V} \\ \left(\overline{\mathrm{OE}}, \mathrm{~T}, \bar{R}_{\mathrm{n}}\right) \end{array} \end{aligned}$ |
| $\mathrm{I}_{\text {BVIT }}$ | Input HIGH Current Breakdown Test (I/O) |  |  | 0.1 | mA | Max | $\begin{aligned} & \mathrm{V}_{\mathrm{IN}}=5.5 \mathrm{~V} \\ & \left(\mathrm{~A}_{\mathrm{n}}, \mathrm{~B}_{\mathrm{n}}\right) \end{aligned}$ |
| ILL | Input LOW <br> Current |  |  | $\begin{aligned} & \hline-150 \\ & -100 \end{aligned}$ | $\begin{aligned} & \mu \mathrm{A} \\ & \mu \mathrm{~A} \end{aligned}$ | $\begin{aligned} & \text { Max } \\ & \operatorname{Max} \end{aligned}$ | $\begin{aligned} & \mathrm{V}_{\mathrm{IN}}=0.5 \mathrm{~V}\left(\mathrm{~T} / \overline{\mathrm{R}}_{\mathrm{n}}, \mathrm{~A}_{\mathrm{n}}, \mathrm{~B}_{\mathrm{n}}\right) \\ & \mathrm{V}_{\mathrm{IN}}=0.5 \mathrm{~V}\left(\overline{\mathrm{OE}}_{\mathrm{n}}\right) \end{aligned}$ |
| los | Output Short-Circuit Current | -100 |  | -225 | mA | Max | $\begin{aligned} & V_{\text {OUT }}=0 \mathrm{~V} \\ & \left(A_{n}, B_{n}\right) \end{aligned}$ |
| $\begin{aligned} & \hline \mathrm{I}_{\mathrm{H}}+ \\ & \mathrm{I}_{\mathrm{OZH}} \end{aligned}$ | Output Leakage Current |  | 0 | 25 | $\mu \mathrm{A}$ | Max | $\begin{aligned} & V_{\text {OUT }}=2.7 \mathrm{~V} \\ & \left(\mathrm{~A}_{\mathrm{n}}, \mathrm{~B}_{\mathrm{n}}\right) \end{aligned}$ |
| $\begin{aligned} & \hline \mathrm{I}_{\mathrm{L}+}+ \\ & \mathrm{I}_{\mathrm{OZL}} \end{aligned}$ | Output Leakage Current |  | -20 | -150 | $\mu \mathrm{A}$ | Max | $\begin{aligned} & \mathrm{V}_{\text {OUT }}=0.5 \mathrm{~V} \\ & \left(\mathrm{~A}_{\mathrm{n}}, \mathrm{~B}_{\mathrm{n}}\right) \end{aligned}$ |
| $\mathrm{I}_{\text {CEX }}$ | Output HIGH Leakage Current |  |  | 50 | $\mu \mathrm{A}$ | Max | $\begin{aligned} & \mathrm{V}_{\text {OUT }}=\mathrm{V}_{\mathrm{CC}} \\ & \left(\mathrm{~A}_{\mathrm{n}}, \mathrm{~B}_{\mathrm{n}}\right) \end{aligned}$ |
| $\mathrm{V}_{1 \mathrm{D}}$ | Input Leakage Test | 4.75 |  |  | v | 0.0 | $\mathrm{I}_{\mathrm{ID}}=1.9 \mu \mathrm{~A}$ <br> All Other Pins Grounded |
| $1{ }_{\text {OD }}$ | Output Circuit Leakage Current |  |  | 3.75 | $\mu \mathrm{A}$ | 0.0 | $V_{I O D}=150 \mathrm{mV}$ <br> All Other Pins Grounded |
| 'zz | Bus Drainage Test |  |  | 100 | $\mu \mathrm{A}$ | 0.0 | $\begin{aligned} & \begin{array}{l} \mathrm{V}_{\text {OUT }}=5.25 \mathrm{~V} \\ \left(\mathrm{~A}_{n}, B_{n}\right) \end{array} \end{aligned}$ |
| ${ }^{\text {cCH }}$ | Power Supply Current |  | 70 | 105 | mA | Max | $\mathrm{V}_{\mathrm{O}}=\mathrm{HIGH}$ |
| ${ }_{\text {CCL }}$ | Power Supply Current |  | 127 | 165 | mA | Max | $\mathrm{V}_{\mathrm{O}}=$ LOW |
| ${ }^{\text {ccz }}$ | Power Supply Current |  | 71 | 105 | mA | Max | $\mathrm{V}_{\mathrm{O}}=\mathrm{HIGH} \mathrm{Z}$ |
| $\mathrm{C}_{\text {IN }}$ | Input Capacitance |  | 8.0 |  | pF | 5.0 | $\overline{\mathrm{OE}, \mathrm{T}} \mathrm{T} \overline{\mathrm{R}}$ |
|  |  |  | 17.0 |  | pF | 5.0 | $\mathrm{A}_{\mathrm{n}}, \mathrm{B}_{\mathrm{n}}$ |

## AC Electrical Characteristics

| Symbol | Parameter | $\begin{gathered} \mathrm{T}_{\mathrm{A}}=+25^{\circ} \mathrm{C} \\ \mathrm{v}_{\mathrm{CC}}=+5.0 \mathrm{~V} \\ \mathrm{C}_{\mathrm{L}}=50 \mathrm{pFF} \end{gathered}$ |  |  | $\begin{gathered} \mathrm{T}_{\mathrm{A}}=0^{\circ} \mathrm{C} \text { to }+70^{\circ} \mathrm{C} \\ \mathrm{~V}_{\mathrm{cC}}=+5.0 \mathrm{~V} \\ \mathrm{C}_{\mathrm{L}}=50 \mathrm{pF} \end{gathered}$ |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Typ | Max | Min | Max |  |
| ${ }_{\text {tpLH }}$ | Propagation Delay | 1.3 | 2.7 | 4.3 | 1.3 | 4.3 | ns |
| $t_{\text {P } \mathrm{HL}}$ | $A_{n}$ to $B_{n}$ or $B_{n}$ to $A_{n}$ | 1.3 | 2.2 | 4.3 | 1.3 | 4.3 |  |
| ${ }_{\text {tPZH }}$ | Output Enable Time | 3.9 | 6.9 | 13.9 | 3.9 | 13.9 | ns |
| tpzL |  | 3.9 | 9.7 | 13.9 | 3.9 | 13.9 |  |
| $t_{\text {P }}$ | Output Disable Time | 1.8 | 3.9 | 6.3 | 1.8 | 6.3 | ns |
| tpLz |  | 1.8 | 4.4 | 6.3 | 1.8 | 6.3 |  |

## Extended AC Characteristics

| Symbol | Parameter |  | $+70^{\circ} \mathrm{C}$ <br> OV <br> F <br> itching | $\begin{array}{r} \mathrm{T}_{\mathrm{A}}=0 \\ \mathrm{~V}_{\mathrm{C}} \\ \mathrm{C}_{\mathrm{L}} \end{array}$ | $+70^{\circ} \mathrm{C}$ <br> OV pF | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Max | Min | Max |  |
| $\begin{aligned} & \hline \mathrm{t}_{\mathrm{PLH}} \\ & \mathrm{t}_{\mathrm{PHL}} \end{aligned}$ | Propagation Delay $A_{n}$ to $B_{n}$ or $B_{n}$ to $A_{n}$ | $\begin{aligned} & 1.3 \\ & 1.3 \end{aligned}$ | $\begin{aligned} & \hline 5.8 \\ & 5.8 \end{aligned}$ | $\begin{aligned} & 3.2 \\ & 3.2 \end{aligned}$ | $\begin{aligned} & \hline 8.2 \\ & 8.2 \end{aligned}$ | ns |
| $\begin{aligned} & \mathrm{t}_{\mathrm{PZH}} \\ & \mathrm{t}_{\mathrm{PZL}} \end{aligned}$ | Output Enable Time | $\begin{aligned} & 3.9 \\ & 3.9 \end{aligned}$ | $\begin{aligned} & 14.6 \\ & 14.6 \end{aligned}$ |  |  | ns |
| $\begin{aligned} & \hline \mathrm{t}_{\mathrm{PHZ}} \\ & \mathrm{t}_{\mathrm{PLZ}} \end{aligned}$ | Output Disable Time | $\begin{aligned} & 1.8 \\ & 1.8 \end{aligned}$ | $\begin{aligned} & \hline 6.3 \\ & 6.3 \end{aligned}$ |  |  | ns |
| $\mathrm{t}_{\mathrm{OSHL}}$ <br> (Note 3) | Pin-to-Pin Skew for HL Transitions |  | 1.2 |  |  | ns |
| tosth <br> (Note 3) | Pin-to-Pin Skew for LH Transitions |  | 2.2 |  |  | ns |
| tost <br> (Note 3) | Pin-to-Pin Skew for HL/LH Transitions | 2.5 |  |  |  | ns |
| Note 3: Skew is defined as the absolute value of the difference between the actual propagation delays for any two outputs of the same device. The specification applies to any outputs switching HIGH-to-LOW (toshl) LOW-to-HIGH (tosLh), or HIGH-to-LOW and/or LOW-to-HIGH (tost). Specifications guaranteed with all outputs switching in phase. <br> Note 4: This specification is guaranteed but not tested The limits apply to propagation delays for all paths described switching in phase, i.e., all LOW-to-HIGH, HIGH-to-LOW, 3-STATE-to-HIGH, etc. <br> Note 5: These specifications guaranteed but not tested. The limits represent propagation delays with 250 pF load capacitors in place of the 50 pF load capacitors in the standard AC load. This specification pertains to single output switching only. |  |  |  |  |  |  |
|  |  |  |  |  |  |  |  |  | capacitors in the standard AC load. This specification pertains to single output switching only.

Physical Dimensions inches (millimeters) unless otherwise noted


44-Lead Plastic Lead Chip Carrier (PLCC), JEDEC MO-047, 0.650 Square
Package Number V44A

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)


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